Spring 2006

TMA4275 LIFETIME ANALYSIS

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GOALS

After finishing this course you should

- know the most common concepts and distributions from lifetime modeling
- be able to use graphical methods for description and comparison of lifetime data
- be able to use statistical methods for statistical inference (estimation, confidence interval, hypothesis testing) of lifetime data
- be able to analyze lifetime data by using computer software (MINITAB)

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About the course	The course gives an introduction to stochastic modelling and statistical methods for use in lifetime data analysis, with particular view to applications in reliability analysis and medicine.	
	The lectures are based on knowledge from TMA4240/TMA4245 Statistics or equivalent. It will be an advantage to have taken one of the courses TPK4120 Industrial safety and reliability, TMA4260 Industrial statistics, and TMA4255 Design of experiments and applied statistical methods.	
	<i>Contents:</i> Basic concepts in lifetime modelling. Censored observations. Nonparametric estimation and graphical plotting for lifetime data (Kaplan-Meier, Nelson-plot). Estimation and testing in parametric lifetime distributions. Analysis of lifetimes with covariates. (Cox-regression, accelerated lifetime testing). Modelling and analysis of recurrent events. Nonhomogeneous Poisson-processes. Nelson-Aalen estimators. Bayesian lifetime analysis.	
	 Weekly hours: Spring: 4F+1Ø+7S = 7,5 SP Course type: Lectures and exercises with the use of a computer (MINITAB). Lectures may be given in English. Portfolio assessment is the basis for the grade awarded in the course. This portfolio comprises a written final examination 80% and selected parts of the exercises 20%. The results for the constituent parts are to be given in %-points, while the grade for the whole portfolio (course grade) is given by the letter grading system. Retake of examination may be given as an oral examination. 	
Lecturer	Professor <u>Bo Lindqvist</u> , room 1129, Sentralbygg II. Tlf. (735)93532 Office hours: To be announced. Email: <u>bo@math.ntnu.no</u>	
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Exercise lab teacher	Research assistant <u>Anastasia Ushakova</u> , room 1126, Sentralbygg II. Tlf. (735)91671 Office hours: To be announced. Email: <u>anastasi@math.ntnu.no</u>
Course book	The main source will be the book Rausand & Høyland: System Reliability Theory: Models, Statistical Methods, and Applications, 2nd Edition. Wiley 2004.
	Alternatively you may use the 1st edition: Høyland & Rausand: System Reliability Theory: Models and Statistical Methods, Wiley 1994.
	Notes/copies about certain topics will be handed out. Foils from the lectures can be downloaded as pdf-files from this website.
Curriculum	THE FINAL CURRICULUM FOR spring 2005 can be found here.
Exercises	Some exercises (including the obligatory ones) require use of the statistics computer package MINITAB, see http://www.ntnu.no/itea.info/programvare/minitab.html Note that NTNU has an unlimited site licence for Windows and Macintosh for installation of MINITAB on NTNUs area and on private machines of students and staff. MINITAB is also available on computer labs <u>Gombe</u> (Realfagbygget R90, 24 machines) and <u>Chobe</u> (Realfagbygget R91, 12 machines).
Final exam:	May 26, 2006. Written. 4 hours. Permitted aids: A. All printed or handwritten aids permitted. All calculators permitted.

REL	IMINARY C	URRICULU	M AND	LECTU	RE PLA
Week No.	Literature H & R	Literature R & H (2nd ed.)	Торіс	Comment H & R	Comment R & H
3	2.1-2.4-2.7, 2.9- 2.11, 2.14, 2.17 Notes on "Log- location-scale" (Lecture week 2).	2.1-2.14, 2.17, 2.20 Notes on "Log- location- scale" (Lecture week 2).	Probability distributions for lifetimes. Fundamental properties. Important distributions and properties.	Only main results in 2.14 are covered.	Only main results in 2.17 are covered.
4-5	Ch. 9 The note "About the exponential distribution " (Lecture week 3).	11.1-11.3, 11.5 The note "About the exponential distribution " (Lecture week 3).	Lifetime data. Censoring. Nonparametric methods. Plotting (TTT, Kaplan-Meier, Nelson- Aalen.)		
6-8	Notes on "Likelihood construction" and "On parametric inference" (Lecture week 5).	11.4 Notes on "Likelihood construction" and "On parametric inference" (Lecture week 5).	Parametric estimation and testing. Maximum likelihood. Information matrix. Confidence intervals. Probability plots (MINITAB).		
9-10			No lectures		
11-13	Ch. 10. Notes on "Survival regression" (Lecture week 8) and "Medical study" (Lecture week 9).	Ch. 12. Notes on "Survival regression" (Lecture week 8) and "Medical study" (Lecture week 9).	Regression methods. Covariates. Weibull regression. Cox- regression. Accellerated lifetime testing.	P. 428 and rest of chapter 10 are not covered.	Example 12.2 page 532 and rest of Ch. 12 are not covered.

14 and 16-17	Ch. 7	Ch. 7	Point processes. Recurrent events. Repairable systems. Poisson processes and renewal. Modelling and statistical analysis of data. Likelihood- methods.	Only selected parts of 7.3 are treated in class. From pages 293-313 are just "Superimposed " s. 301-302 covered.	The following is covered (not always in detail): 7.1 only to 7.1.3; most of 7.2, but only to 7.2.6; 7.3 to 7.3.4; but in addition 7.3.8; most of 7.4. Pooled versions of Laplace and Mil-Hdbk tests (as used by MINITAB).
15			Easter vacation		
18	Ch. 11	Ch. 13	Bayesian lifetime analysis	Selected parts of 11.1-11.5 are covered.	Selected parts of 13.1-13.5 are covered.
19	Earlier exams		Review		

RELIABILITY

Common technical definition of reliability:

The probability that a system or a component will perform its intended task, under given operational conditions, for a specified time period.

LIFE TIMES (SURVIVAL DATA)

- Time to failure of a component or a system
- Number of cycles to failure (fatigue testing)
- Time to next epileptic seizure for patient
- Times of failure and repair of a machine

WHY COLLECT AND ANALYZE LIFETIME/SURVIVAL/RELIABILITY DATA?

- Assess reliability of a system/component/product
- Compare two or more products with respect to reliability
- Predict product reliability in the design phase
- Predict warranty claims for a product in the market

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SPECIAL ASPECTS OF LIFETIME ANALYSIS

- Definition of starting time and failure time are difficult
- Definition of time scale (operation time, calendar time, number of cycles)
- Censored data (what do we do with units that have not failed within the observation period?)
- Effect of environmental conditions
- What if a unit fails of another cause than the one we would like to study? ("competing risks")
- Recurrent events what if the system can fail several times; how to analyze recurring stages of a disease?

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BALL BEARINGS FAILURE DATA

Data: Millions of revolutions to fatigue failure for 23 units

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51,96	54,12	55,56	67,80	68,64	68,64	68,88	84,12
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Lieblein and Zelen Ball Bearing Failure Data



- How to estimate the distribution of the failure time whe there are censored observations?
- Probability of failure before 100 hours?
- Failure rate by 100 hours?
- Proportion failed after 10^5 hours?

IC Data Failure Pattern



Valve Seat Replacement Times (Nelson and Doganaksoy 1989)

Data collected from valve seats from a fleet of 41 diesel engines (days of operation)

- Each engine has 16 valves
- Does the replacement rate increase with age?
- How many replacement valves will be needed in the future?
- Can valve life in these systems be modeled as a renewal process?



Estimate of Number of Valve Seat $\mu(t)$



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